

IN THE CLAIMS

Please Amend the Claims in accordance with the following mark-up copy:

1. (Currently Amended) A comparator circuit, comprising:

 a pair of differential inputs for receiving a differential data signal pair;
 a single-ended input for receiving a single-ended data signal;
 a reference combiner, whereby a reference value for detecting said single-ended data signal is derived in conformity with analog values of both signals of said differential signal pair; and
 a single-ended comparator for comparing an analog value of said single-ended input data signal with said reference value, and having an output representative of a digital binary state of said single-ended data signal, whereby said single-ended signal is detected in conformity with a common mode value of said differential signal pair.

2. (Currently Amended) The comparator circuit of Claim 1, wherein said reference combiner comprises:

 a first controlled current source having an input coupled to a first signal of said differential data signal pair;
 a second controlled current source having an input coupled to a second signal of said differential data signal pair; and
 a current summing junction for summing an output of said first

controlled current source and an output of said second controlled current source for providing said reference value.

3. (Currently Amended) The comparator circuit of Claim 2, wherein said single-ended comparator comprises a third controlled current source having an input coupled to said single-ended input and an output coupled to said current summing junction for comparing said analog value of said single-ended data signal to said reference value.

4. (Currently Amended) The comparator circuit of Claim 3, wherein said first controlled current source comprises a first transistor having a gate coupled to said first signal of said differential data signal pair, wherein said second controlled current source comprises a second transistor having a gate coupled to said second signal of said differential data signal pair, and wherein said third controlled current source comprises a third transistor having a gate coupled to said single-ended input.

5. (Currently Amended) The comparator circuit of Claim 4, further comprising a fixed current source coupled to said current summing junction, whereby said comparator detects a difference between said analog value of said single-ended signal and an average of said analog values of said first signal and said second signal of said

differential data signal pair.

6. (Currently Amended) The comparator circuit of Claim 4, further comprising a first resistance coupled to a second channel connection of said third transistor, whereby a gain of [[a]] ~~singlential~~ said output of singlential single-ended comparator is determined.

7. (Currently Amended) The comparator circuit of Claim 6, further comprising a differential comparator circuit for comparing said analog values of said differential data signal pair of ~~differential inputs~~, said differential comparator circuit comprising a fourth transistor having a gate coupled to said first signal of said differential data signal pair, a fifth transistor having a gate coupled to said second signal of said differential data signal pair and a first channel connection coupled to a second resistance for providing active mode operation, a second current source coupled to a channel connection of said fourth transistor and a second channel connection of said fifth transistor, whereby said differential comparator detects a difference between said first signal and said second signal of said differential data signal pair, and wherein said first resistance has a resistance value twice that of said second resistance, whereby a gain of said active mode of said differential comparator is equal to a gain of

said single-ended comparator.

8. (Currently Amended) The comparator circuit of Claim 2, wherein said first controlled current source comprises a first transistor having a gate coupled to said first signal of said differential data signal pair, and wherein said second controlled current source comprises a second transistor having a gate coupled to said second signal of said differential data signal pair.

9. (Currently Amended) The comparator circuit of Claim 8, further comprising a fixed current source coupled to said current summing junction, whereby said reference combiner supplies a current in conformity with an average of said ~~non-inverted signal and said inverted signal~~ of said analog values of said differential data signal pair to said fixed current source.

10. (Currently Amended) A method for detecting a single-ended signal, said method comprising:

receiving a single-ended data signal;
receiving a differential data signal pair;
combining both signals of said differential signal pair to provide a reference value; and
comparing an analog value of said single-ended signal to said reference value, whereby a binary logic state of said single-ended

signal is detected in conformity with analog values of both signals of said differential signal pair.

11. (Currently Amended) The method of Claim 10, wherein said combining comprises:

controlling a first controlled current source with an analog value of a first signal of said differential data signal pair;
controlling a second controlled current source with an analog value of a second signal of said differential data signal pair; and
summing an output of said first controlled current source and an output of said second controlled current source to provide said reference value.

12. (Currently Amended) The method of Claim 11, wherein said comparing comprises controlling a third controlled current source with said single-ended data signal, and wherein said summing further sums an output of said third controlled current source.

13. (Currently Amended) The method of Claim 12, wherein said summing further sums a current supplied by a fixed current source, whereby said comparing detects a difference between said analog value of single-ended signal and an average of said analog value of said first signal and said analog value of said second signal of said differential data signal pair.

14. (Currently Amended) The method of Claim 12, further comprising converting a current result of said summing to a voltage via a first resistance, whereby said comparing is performed in an active mode, producing a voltage substantially linearly proportional to a difference between said reference value and said analog value of said single-ended signal in a region where said reference value and said analog value of said single-ended signal are substantially equal.

15. (Currently Amended) The method of Claim 14, further comprising second comparing said analog values of said pair of differential data signals inputs to each other to provide a differential pair detected output, wherein said second comparing produces a second voltage via converting a difference current to said second voltage via a second resistor, and wherein said first resistor has a resistance substantially twice that of said second resistor, whereby a gain of said first comparing and a gain of said second comparing are substantially equal.

16. (Currently Amended) A comparator circuit, comprising:

 a pair of differential inputs for receiving a differential data signal pair;

 a single-ended input for receiving a single-ended data signal;

 a first transistor having a gate coupled to a first signal of said differential signal pair;

 a second transistor having a gate coupled to a second signal of said differential signal pair;

 a third transistor having a gate coupled to said single-ended input; and

 a fixed current source coupled to a common connection of a first channel connection of each of said first transistor, said second transistor and said third transistor, whereby said single-ended data signal is compared to a common-mode value of said differential signal pair, and wherein an output provided from a second channel connection of said third transistor is representative of a binary state of said single-ended data signal.

17. (Currently Amended) The comparator circuit of Claim 16, further comprising a first resistance coupled to [[a]] said second channel connection of said third transistor, whereby a first gain of a single-ended output of said comparator is determined in an active region of operation of said comparator.

18. (Currently Amended) The comparator circuit of Claim 17, further comprising:

a fourth transistor having a gate coupled to said first signal of said differential data signal pair;

a fifth transistor having a gate coupled to said second signal of said differential data signal pair;

a second fixed current source coupled to a common connection of a first channel connection of each of said fourth transistor and said fifth transistor, whereby said first signal and said second signal of said differential data signal pair are compared; and

a second resistance coupled to a second channel connection of said fifth transistor, whereby a gain of a differential output of said comparator is determined, and wherein a resistance value of said first resistance is substantially twice a resistance value of said second resistance, whereby said first gain is equal to a second gain of said differential output in an active region of operation.